

Notice of References Cited	Application/Control No. 10/022,628	Applicant(s)/Patent Under Reexamination HRABIK ET AL.	
	Examiner Feben M. Haile	Art Unit 2663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,128,282	10-2000	Liebetreu et al.	370/235
*	B	US-6,885,639	04-2005	Kamiya, Satoshi	370/235
*	C	US-6,895,015	05-2005	Chiang et al.	370/429
*	D	US-2004/0160978	08-2004	Jones et al.	370/461
	E	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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